

## Notice of R ferenc s Cited

Application/Control No.	Applicant(s)/Pater Reexamination HEINECK ET AL.	
Examiner	Art Unit	
Christopher W Lattin	2812	Page 1 of 1

## U.S. PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-US006153476A	11-2000	Inaba et al.	438/275
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## FOREIGN PATENT DOCUMENTS

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## NON-PATENT DOCUMENTS

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